P-Channel 20-V (D-S) MOSFET

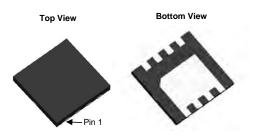
PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A)	Q _g (Typ.)		
- 20	0.0040 at V _{GS} = 10 V	- 52	21.5 nC		
- 20	0.0060 at V _{GS} = 4.5 V	- 40	21.5110		

FEATURES

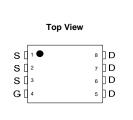
- Halogen-free According to IEC 61249-2-21
 Definition
- TrenchFET[®] Power MOSFET
- 100 % R_a Tested
- Compliant to RoHS Directive 2002/95/EC

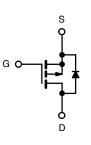
APPLICATIONS

- Load Switch
- Adaptor/Battery Switch



DFN 3x3 EP





P-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 20	v	
Gate-Source Voltage		V _{GS}	± 16	v	
	T _C = 25 °C		- 52	A	
Continuous Drain Current (T ₁ = 150 °C)	T _C = 70 °C	I _D	- 40 ^g		
Continuous Drain Current $(1) = 150^{\circ}$ C)	T _A = 25 °C	U	- 26 ^{b, c}		
	T _A = 70 °C		- 21 ^{b, c}		
Pulsed Drain Current	I _{DM}	- 150			
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	- 40 ^g		
Continuous Cource-Drain Diode Current	T _A = 25 °C	'5	- 4.5 ^{b, c}		
	T _C = 25 °C		54		
Maximum Power Dissipation	T _C = 70 °C	Pn	34.7	w	
	T _A = 25 °C	' D	5.0 ^{b, c}		
	T _A = 70 °C		3.2 ^{b, c}		
Operating Junction and Storage Temperature R	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Temperatur		260	0		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R _{thJA}	20	25	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	1.8	2.3	0/11	

Notes:

a. Based on T_C = 25 °C.

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 10 s.







Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	•						
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0, I_D = -250 \ \mu A$	- 20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 15		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_{\rm D} = -230 \mu{\rm A}$		4.5			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = -250 \ \mu A$	- 1		- 2.2	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 16 V$			± 100	nA	
Zana Osta Malla na Dusia Osmanl		$V_{DS} = -20 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			- 1		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 20 V, V _{GS} = 0 V, T _J = 55 °C			- 10	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le$ - 5 V, V_{GS} = - 10 V	- 30			Α	
		V _{GS} = - 10 V, I _D = - 26 A	0.0040			1	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 21 A		0.0060		Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 26 A		58		S	
Dynamic ^b				<u> </u>			
Input Capacitance	C _{iss}			4595		pF	
Output Capacitance	C _{oss}	V _{DS} = - 10 V, V _{GS} = 0 V, f = 1 MHz		910			
Reverse Transfer Capacitance	C _{rss}			813			
Total Gate Charge	Qg	V _{DS} = - 10 V, V _{GS} = - 10 V, I _D = - 20 A		95.3	143	nC	
				46.5	70		
Gate-Source Charge	Q _{gs}	V_{DS} = - 10 V, V_{GS} = - 4.5 V, I_{D} = - 20 A		13.7			
Gate-Drain Charge	Q _{gd}	-		12.5			
Gate Resistance	Rg	f = 1 MHz	0.4	1.9	3.8	Ω	
Turn-On Delay Time	t _{d(on)}			19	30		
Rise Time	t _r	V_{DD} = - 10 V, R_L = 1 Ω		10	20		
Turn-Off Delay Time	t _{d(off)}	${\rm I}_{\rm D}\cong$ - 10 A, ${\rm V}_{\rm GEN}$ = - 10 V, ${\rm R}_{\rm g}$ = 1 Ω		65	98		
Fall Time	t _f	-		13	20		
Turn-On Delay Time	t _{d(on)}			55	83	ns	
Rise Time	t _r	V_{DD} = - 10 V, R_L = 1 Ω		52	78	-	
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ - 10 A, V_GEN = - 4.5 V, R_g = 1 Ω		53	80		
Fall Time	t _f			25	38		
Drain-Source Body Diode Characteris	tics			·		•	
Continuous Source-Drain Diode Current	ا _S	T _C = 25 °C			- 40	^	
Pulse Diode Forward Current ^a	I _{SM}				- 70	A	
Body Diode Voltage	V _{SD}	I _S = - 1 A		- 0.74	- 1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			42	63	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			25	38	nC	
Reverse Recovery Fall Time	ta	$I_F = -10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{ T}_J = 25 ^\circ\text{C}$		12			
Reverse Recovery Rise Time	t _b			30		ns	

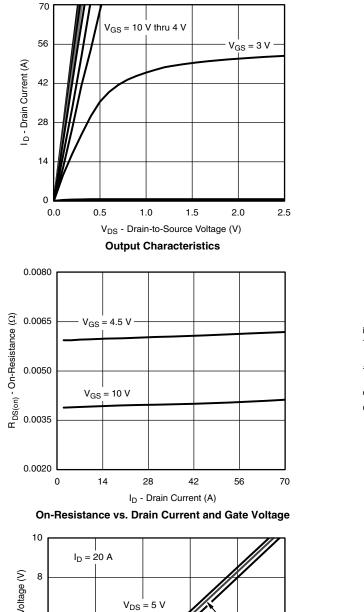
Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

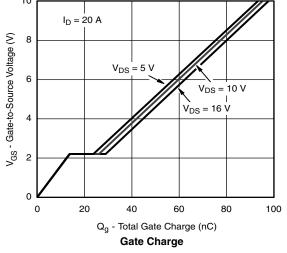
b. Guaranteed by design, not subject to production testing.

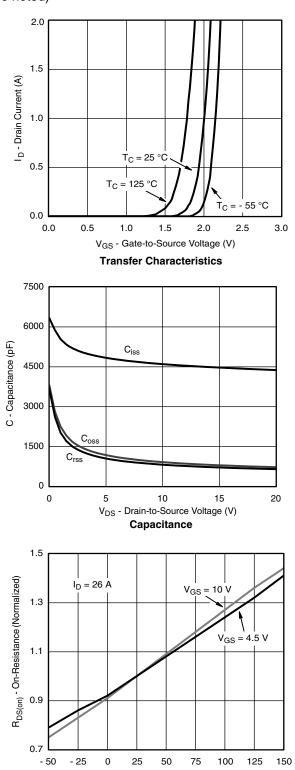
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





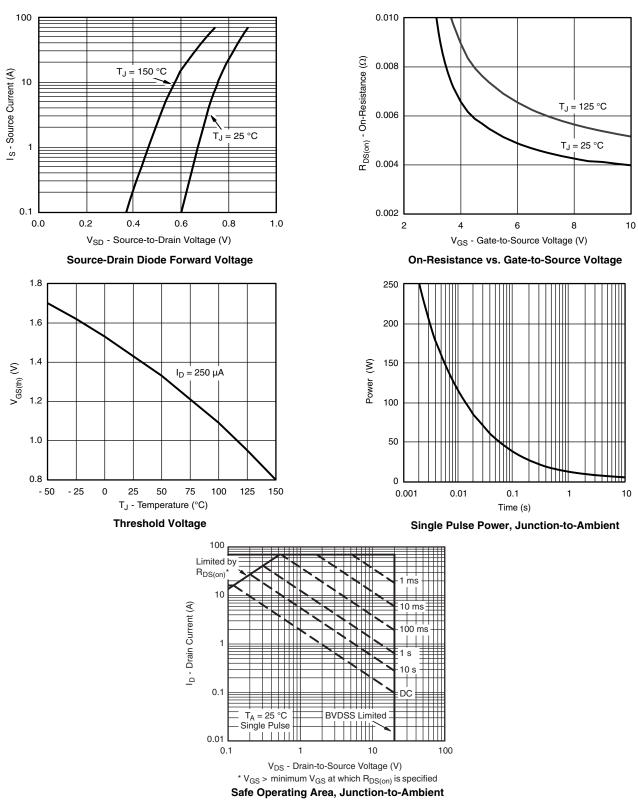
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





T_J - Junction Temperature (°C) On-Resistance vs. Junction Temperature

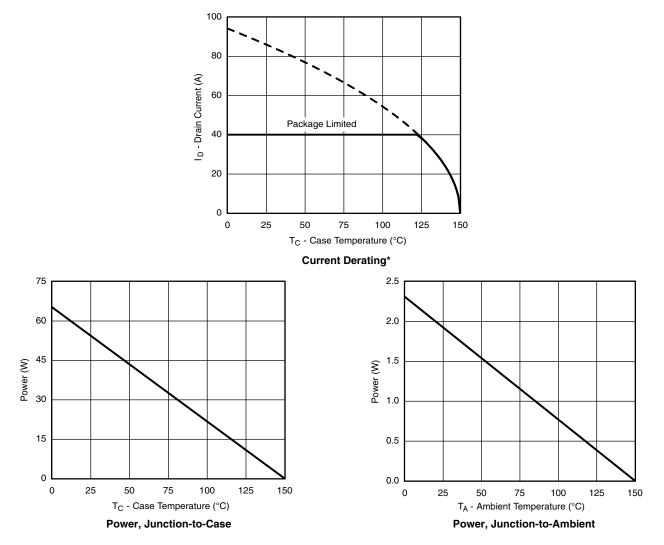




TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



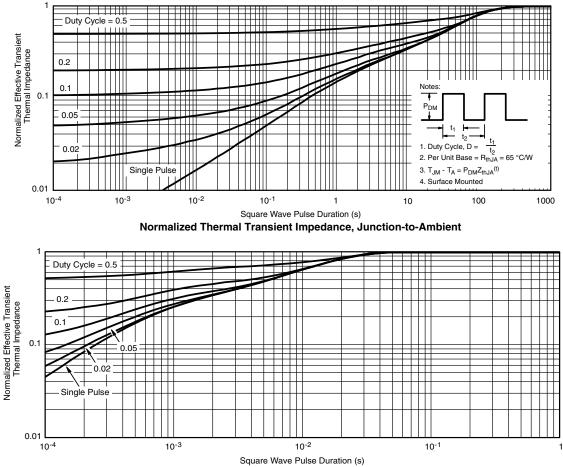




* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

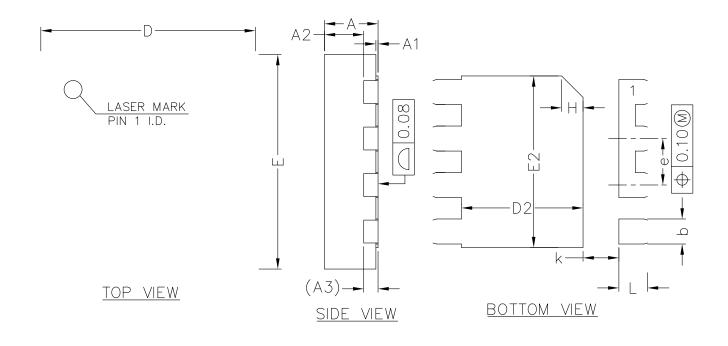


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case







<u>SIDE VIEW</u>

		r		
SYMBOL	MIN	NOM	МАХ	
А	0.70	0.75	0.80	
A1	0.00	0.02	0.05	
A2	0.50	0.55	0.60	
A3	0.20REF			
b	0.30	0.35	0.40	
D	2.90	3.00	3.10	
E	2.90	3.00	3.10	
D2	1.60	1.70	1.80	
E2	2.30	2.40	2.50	
е	0.55	0.65	0.75	
K	0.40	0.50	0.60	
	0.35	0.40	0.45	

COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)



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